MOSFET – Power, Single **N-Channel** 60 V, 5.0 mΩ, 109 A

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFS5C658NLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Parameter Drain-to-Source Voltage Gate-to-Source Voltage			Symbol	Value	Unit V
			V _{DSS}	60	
			V _{GS}	±20	V
Continuous Drain Cur-	Steady State	$T_{C} = 25^{\circ}C$	۱ _D	109	А
rent $R_{\theta JC}$ (Notes 1, 2, 3, 4)		T _C = 100°C		77	
Power Dissipation $R_{\theta JC}$ (Notes 1, 2, 3)		T _C = 25°C	PD	114	W
		T _C = 100°C		57	
Continuous Drain Current $R_{\theta JA}$ (Notes 1 & 3, 4)	Steady State	T _A = 25°C	Ι _D	18	А
		T _A = 100°C		15	
Power Dissipation $R_{\theta JA}$ (Notes 1, 3)		$T_A = 25^{\circ}C$	PD	3.2	W
		T _A = 100°C		2.2	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	440	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			۱ _S	127	А
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 5.0 A)			E _{AS}	142	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

ng those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	1.3	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.

3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

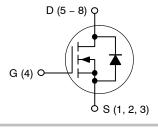


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
60 V	5.0 mΩ @ 10 V	109 A
60 V	7.3 mΩ @ 4.5 V	109 A





MARKING DIAGRAM

bΟ

h D



(Note: Microdot may be in either location)

= Work Week = Pb-Free Package

ww

ORDERING INFORMATION

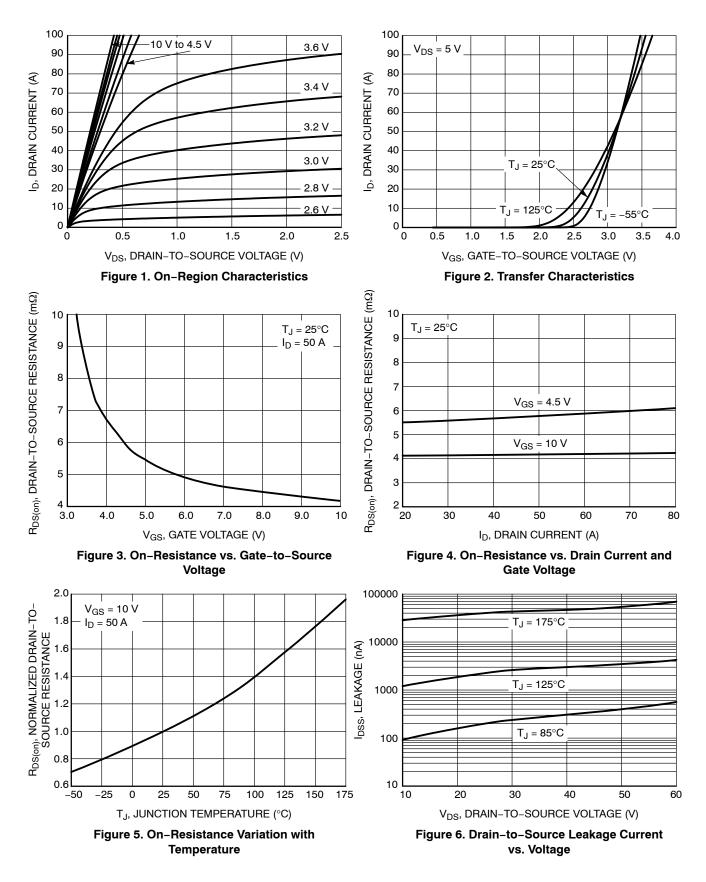
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

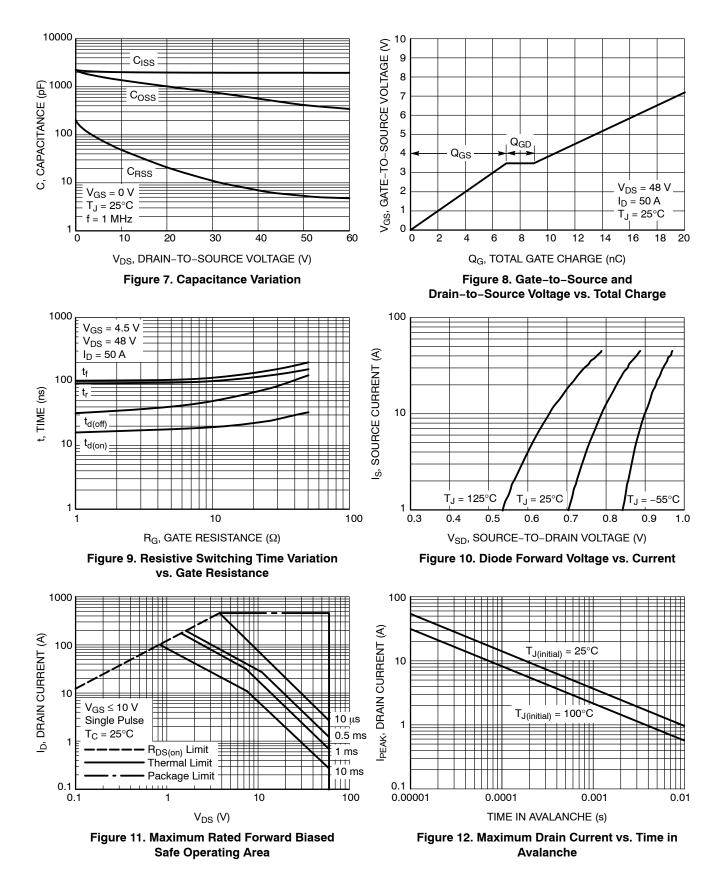
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS		-					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A		60			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 60 V	$T_J = 25^{\circ}C$			10	μΑ
			T _J = 125°C			250	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 75 \mu A$		1.2		2.2	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 50 A			4.2	5.0	mΩ
		V _{GS} = 4.5 V,	V_{GS} = 4.5 V, I _D = 50 A		5.8	7.3	1
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I	_D = 50 A		100		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 25 V			1935		pF
Output Capacitance	C _{oss}				890		-
Reverse Transfer Capacitance	C _{rss}				16		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48 \text{ V}, I_D = 50 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 48 \text{ V}, I_D = 50 \text{ A}$			12		nC
Threshold Gate Charge	Q _{G(TH)}				3.5		nC
Gate-to-Source Charge	Q _{GS}				7		
Gate-to-Drain Charge	Q _{GD}				2.4		
Total Gate Charge	Q _{G(TOT)}				27		nC
SWITCHING CHARACTERISTICS (No	te 6)						
Turn-On Delay Time	t _{d(on)}				16		ns
Rise Time	t _r	V _{GS} = 4.5 V, V	ns = 48 V,		96		1
Turn-Off Delay Time	t _{d(off)}	V_{GS} = 4.5 V, V_{DS} = 48 V, I_{D} = 50 A			36		
Fall Time	t _f				105		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage		$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		0.9	1.2	V
		I _S = 50 A	T _J = 125°C		0.8		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/µs, I _S = 50 A			39		ns
Charge Time	t _a				21		1
Discharge Time	t _b				18		1
Reverse Recovery Charge	Q _{RR}				15		nC

5. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

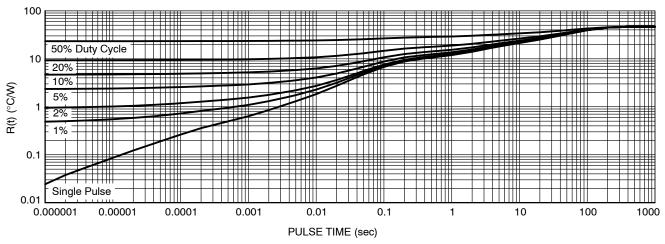


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS5C658NLTAG	658L	WDFN8 (Pb–Free)	1500 / Tape & Reel
NVTFS5C658NLWFTAG	58LW	WDFN8 (Pb-Free)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.